

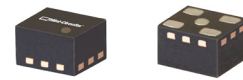
# Ultra Low Noise, High Current E-PHEMT Transistor

## TAV1-541+

50Ω 0.045 to 6 GHz

### The Big Deal

- Low Noise Figure, 0.4 dB
- Gain, 24 dB typ. at 0.9 GHz
- High OIP3, +32 dBm



CASE STYLE: TE2769

### Product Overview

TAV1-541+ is a low noise, high IP3 transistor device manufactured using E-PHEMT\* technology enabling it to work with a single positive supply voltage. It has outstanding Noise figure, particularly below 2.5 GHz, and when combining this noise figure with IP3 performance in a single device it makes it an ideal amplifier for multiple applications.

### Key Features

Feature	Advantages
Wideband, 0.045 to 6 GHz	Use in multiple applications: UHF, VHF, communication infrastructure
High Gain, Low noise figure	High Gain limits the effect of noise figure due to previous stages
Small size, 1.18 x 1.42 x 0.85 mm, MCLP package	Small foot print saves space in dense layouts while providing low inductance, repeatable transitions, and excellent thermal contact to the PCB.

\* Enhancement mode Pseudomorphic High Electron Mobility Transistor.



# Ultra Low Noise, High Current E-PHEMT Transistor

## 0.045-6 GHz

### Product Features

- Low Noise Figure, 0.4 dB
- Gain, 24 dB typ. at 0.9 GHz
- High Output IP3, +32 dBm at 2 GHz, 60mA, 4V
- Output Power at 1dB compression, +21dBm, 60mA, 4V
- Wide bandwidth
- External biasing and matching required



## TAV1-541+

CASE STYLE: TE2769

### +RoHS Compliant

The +Suffix identifies RoHS Compliance. See our web site for RoHS Compliance methodologies and qualifications

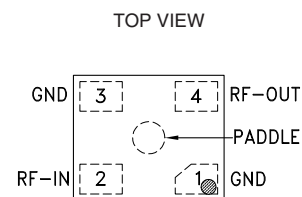
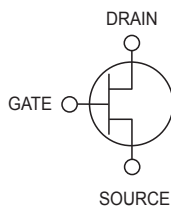
### Typical Applications

- Cellular
- ISM
- GSM
- WCDMA
- WiMax
- WLAN
- UNII and HIPERLAN

### General Description

TAV1-541+ is a low noise, high IP3 transistor device manufactured using E-PHEMT\* technology enabling it to work with a single positive supply voltage. It has outstanding Noise figure, particularly below 2.5 GHz, and when combining this noise figure with IP3 performance in a single device it makes it an ideal amplifier for multiple applications.

### simplified schematic and pin description



Function	Pad Number	Description
RF-IN	2	Gate used for RF input
RF-OUT	4	Drain used for RF output
GND	1,3 and Paddle	Source terminal and Paddle, normally connected to ground.

\* Enhancement mode Pseudomorphic High Electron Mobility Transistor.

Electrical Specifications at  $T_{AMB}=25^{\circ}\text{C}$ , Frequency 0.045 to 6 GHz

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
<b>DC Specifications</b>						
$V_{GS}$	Operational Gate Voltage	$V_{DS}=3\text{V}, I_{DS}=60\text{ mA}$	0.37	0.48	0.69	V
$V_{TH}$	Threshold Voltage	$V_{DS}=3\text{V}, I_{DS}=4\text{ mA}$	0.18	0.26	0.38	V
$I_{DSS}$	Saturated Drain Current	$V_{DS}=3\text{V}, V_{GS}=0\text{ V}$	—	1.0	5.0	$\mu\text{A}$
$G_M$	Transconductance	$\Delta I_D = \Delta V_{GS} / \Delta V_{GS}$ $I_D = I_{DSS} + 0.05 \Delta V_{GS}$	230	392	560	mS
$I_{GSS}$	Gate leakage Current	$V_{GD}=V_{GS}=-3\text{V}$	—	—	200	$\mu\text{A}$
<b>RF Specifications<sup>1</sup>, Z0=50 Ohms (Figure 1)</b>						
NF	Noise Figure	$V_{DS}=3\text{V}, I_{DS}=60\text{ mA}$ $V_{DS}=4\text{V}, I_{DS}=60\text{ mA}$	f=0.9 GHz f=2.0 GHz f=3.9 GHz f=5.8 GHz	— 0.4 0.6 0.9 1.4	0.9	dB
Gain	Gain	$V_{DS}=3\text{V}, I_{DS}=60\text{ mA}$ $V_{DS}=4\text{V}, I_{DS}=60\text{ mA}$	f=0.9 GHz f=2.0 GHz f=3.9 GHz f=5.8 GHz	16.4 24.1 18.6 13.3 9.3	20.4	dB
OIP3	Output IP3	$V_{DS}=3\text{V}, I_{DS}=60\text{ mA}$ $V_{DS}=4\text{V}, I_{DS}=60\text{ mA}$	f=0.9 GHz f=2.0 GHz f=3.9 GHz f=5.8 GHz	32 31.4 31.7 31.9		dBm
P1dB <sup>2</sup>	Power output at 1 dB Compression	$V_{DS}=3\text{V}, I_{DS}=60\text{ mA}$ $V_{DS}=4\text{V}, I_{DS}=60\text{ mA}$	f=0.9 GHz f=2.0 GHz f=3.9 GHz f=5.8 GHz	18.2 18.4 18.6 18.3		dBm
		$V_{DS}=4\text{V}, I_{DS}=60\text{ mA}$	f=2.0 GHz	20.7		

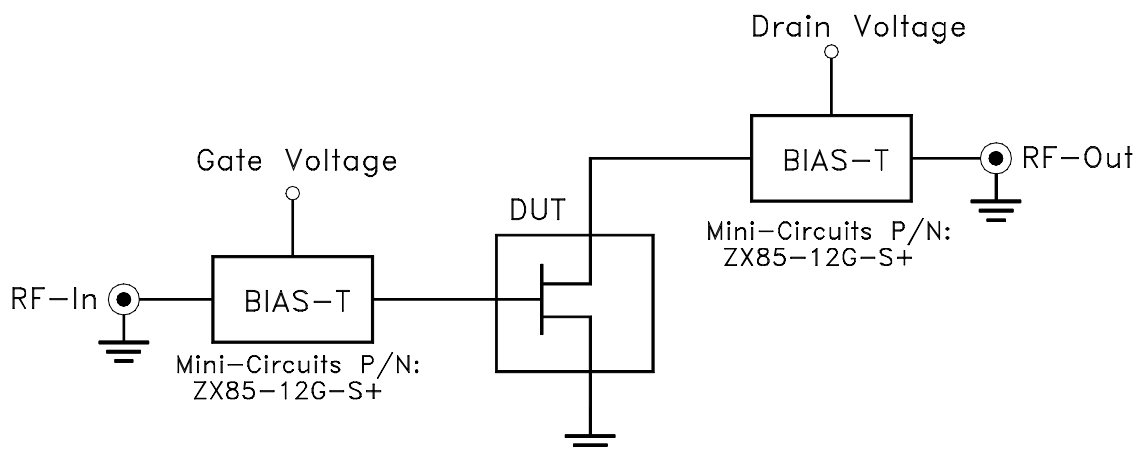
Absolute Maximum Ratings<sup>3</sup>

Symbol	Parameter	Max.	Units
$V_{DS}^{(4)}$	Drain-Source Voltage	5	V
$V_{GS}^{(4)}$	Gate-Source Voltage	-5 to 0.7	V
$V_{GD}^{(4)}$	Gate-Drain Voltage	-5 to 0.7	V
$I_{DS}^{(4)}$	Drain Current	120	mA
$I_{CS}$	Gate Current	2	mA
$P_{DISS}$	Total Dissipated Power	360	mW
$P_{IN}^{(5)}$	RF Input Power	17	dBm
$T_{CH}$	Channel Temperature	150	$^{\circ}\text{C}$
$T_{OP}$	Operating Temperature	-40 to 85	$^{\circ}\text{C}$
$T_{STD}$	Storage Temperature	-65 to 150	$^{\circ}\text{C}$
$\Theta_{JC}$	Thermal Resistance	160	$^{\circ}\text{C}/\text{W}$

Notes:

- Drain current bias is allowed to increase during compression measurement.
- Operation of this device above any one of these parameters may cause permanent damage
- Assumes DC quiescent conditions
- $I_{GS}$  is limited to 2 mA during test.

## Characterization Test Circuit



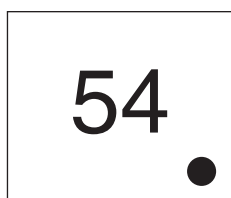
**Fig 1.** Block Diagram of Test Circuit used for characterization. (DUT soldered on Mini-Circuits Test Board TB-TAV1-541+)

Gain, Output power at 1dB compression (P1 dB), Noise Figure and output IP3 (OIP3) are measured using Keysight/Agilent Network Analyzer PNA-X.

**Conditions:**

1. Drain voltage (with reference to source,  $V_{DS}$ )= 3 or 4V as shown.
2. Gate Voltage (with reference to source,  $V_{GS}$ ) is set to obtain desired Drain-Source current ( $I_{DS}$ ) as shown in specification table.
3. Gain: Pin= -25dBm
4. Output IP3 (OIP3): Two tones, spaced 1 MHz apart, 0 dBm/tone at output.
5. No external matching components used.

## Product Marking



Additional Detailed Technical Information	
<i>additional information is available on our dash board. To access this information <a href="#">click here</a></i>	
<b>Performance Data</b>	Data Table
	Swept Graphs
	S-Parameter (S2P Files) Data Set (.zip file)
<b>Case Style</b>	TE2769 <i>Plastic package, exposed paddle, lead finish: Matte-Tin plated</i>
<b>Tape &amp; Reel</b> Standard quantities available on reel	F90 <i>7" reels with 20, 50, 100, 200, 500, 1K, 2K or 3K devices</i>
<b>Suggested Layout for PCB Design</b>	98-PL-665
<b>Evaluation Board</b>	TB-TAV1-541+
<b>Environmental Ratings</b>	ENV08T2

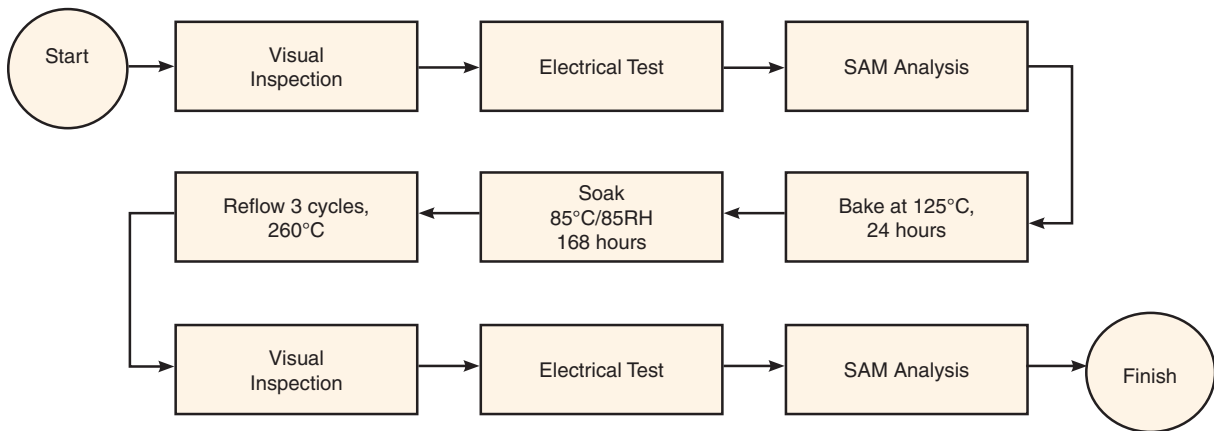
**ESD Rating**

Human Body Model (HBM): Class 1A (250V to <500V) in accordance with ANSI/ESD STM 5.1 - 2001

**MSL Rating**

Moisture Sensitivity: MSL1 in accordance with IPC/JEDEC J-STD-020D

**MSL Test Flow Chart**



**Additional Notes**

- A. Performance and quality attributes and conditions not expressly stated in this specification document are intended to be excluded and do not form a part of this specification document.
- B. Electrical specifications and performance data contained in this specification document are based on Mini-Circuit's applicable established test performance criteria and measurement instructions.
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